

Notice of References Cited

Application/Control No.

10/549,480

Applicant(s)/Patent Under

Reexamination

YAMAKAWA ET AL.

Examiner

KARUNA P. REDDY

Art Unit

1796

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-7,316,864 B2	01-2008	Nakayama et al.	429/217
B	US-			
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D	US-			
E	US-			
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J	US-			
K	US-			
L	US-			
M	US-			

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N	WO 3036744 A1	05-2003	World Intellect	NAKAYAMA et al.	
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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